SHIGA7.004APC PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant :

: Maruyama et al.

Appl. No.

: 10/522,036

Filed

: January 19, 2005

For

CHEMICAL AMPLIFICATION

TYPE POSITIVE PHOTORESIST COMPOSITION AND RESIST

PATTERN FORMING METHOD

Examiner

Lee, Sin J

Group Art Unit

1752

## AMENDMENT AND RESPONSE TO ADVISORYACTION AND FINAL OFFICE ACTION

## Mail Stop AF

Commissioner for Patents P.O. Box 1450

Alexandria, VA 22313-1450

## Dear Sir:

In response to the Advisory Action mailed **January 31, 2007**, and the Office Action mailed **September 15, 2006**, please consider the following amendments and remarks.

Amendments to the claims begin on page 2 of this paper.

Remarks begin on page 13 of this paper.